Search	notes	

Application/Control No.	Applicant(s)/Patent un Reexamination	nder
10/511,991	KAMEI ET AL.	
Examiner	Art Unit	
VAN T. PHAM	2627	

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369	112.08.	3/30/2006	VP
350	214.1	3/30/2006	VP .
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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